TJA1054

Fault-tolerant CAN transceiver

Rev. 04 — 24 September 2009

Product data sheet

1. General description

The TJA1054 is the interface between the protocol controller and the physical bus wires in a Controller Area Network (CAN). It is primarily intended for low-speed applications up to 125 kBd in passenger cars. The device provides differential receive and transmit capability but will switch to single-wire transmitter and/or receiver in error conditions.

The TJA1054T is pin and downwards compatible with the PCA82C252T and the TJA1053T. This means that these two devices can be replaced by the TJA1054T with retention of all functions.

The most important improvements of the TJA1054 with respect to the PCA82C252 and TJA1053 are:

- Very low EME due to a very good matching of the CANL and CANH output signals
- Good EMI, especially in low power modes
- Full wake-up capability during bus failures
- Extended bus failure management including short-circuit of the CANH bus line to V_{CC}
- Support for easy system fault diagnosis
- Two-edge sensitive wake-up input signal via pin WAKE

2. Features

2.1 Optimized for in-car low-speed communication

- Baud rate up to 125 kBd
- Up to 32 nodes can be connected
- Supports unshielded bus wires
- Very low ElectroMagnetic Emission (EME) due to built-in slope control function and a very good matching of the CANL and CANH bus outputs
- Very high ElectroMagnetic Immunity (EMI) in normal and low power operating modes
- Fully integrated receiver filters
- Transmit Data (TxD) dominant time-out function

2.2 Bus failure management

- Supports single-wire transmission modes with ground offset voltages up to 1.5 V
- Automatic switching to single-wire mode in the event of bus failures, even when the CANH bus wire is short-circuited to V_{CC}
- Automatic reset to differential mode if bus failure is removed
- Full wake-up capability during failure modes



Fault-tolerant CAN transceiver

2.3 Protections

- Bus pins short-circuit safe to battery and to ground
- Thermally protected
- Bus lines protected against transients in an automotive environment
- An unpowered node does not disturb the bus lines

2.4 Support for low power modes

- Low current sleep mode and standby mode with wake-up via the bus lines
- Power-on reset flag on the output

3. Quick reference data

Table 1. Quick reference data

 V_{CC} = 4.75 V to 5.25 V; V_{BAT} = 5.0 V to 27 V; V_{STB} = V_{CC} ; T_{vj} = -40 °C to +150 °C; all voltages are defined with respect to ground; positive currents flow into the device; unless otherwise specified.[1][2]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{CC}	supply voltage			4.75	-	5.25	V
V_{BAT}	battery supply voltage on	no time limit		-0.3	-	+40	V
	pin BAT	operating mode	[3]	5.0	-	27	V
		load dump		-	-	40	V
I _{BAT}	battery supply current on pin BAT	sleep mode; $V_{CC} = 0 \text{ V}$; $V_{BAT} = 12 \text{ V}$		-	30	50	μΑ
V_{CANH}	voltage on pin CANH	$V_{CC} = 0 \text{ V to } 5.0 \text{ V};$ $V_{BAT} \ge 0 \text{ V};$ no time limit; with respect to any other pin		-40	-	+40	V
V _{CANL}	voltage on pin CANL	$V_{CC} = 0 \text{ V to } 5.0 \text{ V};$ $V_{BAT} \ge 0 \text{ V};$ no time limit; with respect to any other pin		-40	-	+40	V
ΔV_{CANH}	voltage drop on pin CANH	$I_{CANH} = -40 \text{ mA}$		-	-	1.4	V
ΔV_{CANL}	voltage drop on pin CANL	I _{CANL} = 40 mA		-	-	1.4	V
$t_{\text{PD(L)}}$	propagation delay TXD (LOW) to RXD (LOW)			-	1	-	μs
t _r	bus line output rise time	between 10 % and 90 %; C1 = 10 nF; see <u>Figure 5</u>		-	0.6	-	μs
t _f	bus line output fall time	between 10 % and 90 %; C1 = 1 nF; see <u>Figure 5</u>		-	0.3	-	μs
T_{vj}	virtual junction temperature		<u>[4]</u>	-40	-	+150	°C

^[1] All parameters are guaranteed over the virtual junction temperature range by design, but only 100 % tested at T_{amb} = 125 °C for dies on wafer level, and above this for cased products 100 % tested at T_{amb} = 25 °C, unless otherwise specified.

TJA1054_4 © NXP B.V. 2009. All rights reserved.

^[2] For bare die, all parameters are only guaranteed if the back side of the die is connected to ground.

^[3] A local or remote wake-up event will be signalled at the transceiver pins RXD and \overline{ERR} if $V_{BAT} = 5.3 \text{ V}$ to 27 V see Table 5.

Fault-tolerant CAN transceiver

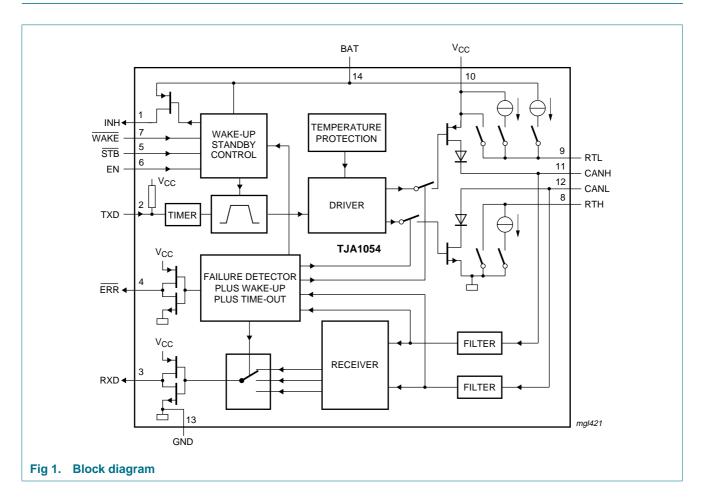
[4] Junction temperature in accordance with "IEC 60747-1". An alternative definition is: $T_{vj} = T_{amb} + P \times R_{th(vj-a)}$ where $R_{th(vj-a)}$ is a fixed value to be used for the calculation of T_{vj} . The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}).

4. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
TJA1054T	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1
TJA1054T/S900	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1
TJA1054U	-	bare die; $1990 \times 2700 \times 375 \ \mu m$	-

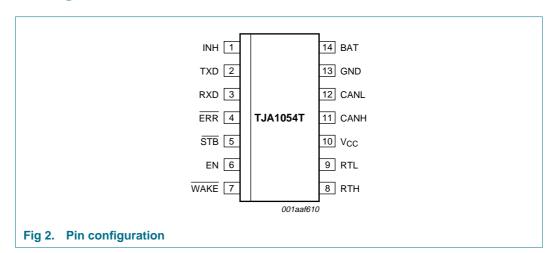
5. Block diagram



Fault-tolerant CAN transceiver

6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
INH	1	inhibit output for switching an external voltage regulator if a wake-up signal occurs
TXD	2	transmit data input for activating the driver to the bus lines
RXD	3	receive data output for reading out the data from the bus lines
ERR	4	error, wake-up and power-on indication output; active LOW in normal operating mode when a bus failure is detected; active LOW in standby and sleep mode when a wake-up is detected; active LOW in power-on standby when a V_{BAT} power-on event is detected
STB	5	standby digital control signal input; together with the input signal on pin EN this input determines the state of the transceiver; see Table 5 and Figure 3
EN	6	enable digital control signal input; together with the input signal on pin STB this input determines the state of the transceiver; see Table 5 and Figure 3
WAKE	7	local wake-up signal input (active LOW); both falling and rising edges are detected
RTH	8	termination resistor connection; in case of a CANH bus wire error the line is terminated with a predefined impedance
RTL	9	termination resistor connection; in case of a CANL bus wire error the line is terminated with a predefined impedance
V_{CC}	10	supply voltage
CANH	11	HIGH-level CAN bus line
CANL	12	LOW-level CAN bus line
GND	13	ground
BAT	14	battery supply voltage

Fault-tolerant CAN transceiver

7. Functional description

The TJA1054 is the interface between the CAN protocol controller and the physical wires of the CAN bus (see <u>Figure 7</u>). It is primarily intended for low-speed applications, up to 125 kBd, in passenger cars. The device provides differential transmit capability to the CAN bus and differential receive capability to the CAN controller.

To reduce EME, the rise and fall slopes are limited. This allows the use of an unshielded twisted pair or a parallel pair of wires for the bus lines. Moreover, the device supports transmission capability on either bus line if one of the wires is corrupted. The failure detection logic automatically selects a suitable transmission mode.

In normal operating mode (no wiring failures) the differential receiver is output on pin RXD (see <u>Figure 1</u>). The differential receiver inputs are connected to pins CANH and CANL through integrated filters. The filtered input signals are also used for the single-wire receivers. The receivers connected to pins CANH and CANL have threshold voltages that ensure a maximum noise margin in single-wire mode.

A timer function (TxD dominant time-out function) has been integrated to prevent the bus lines from being driven into a permanent dominant state (thus blocking the entire network communication) due to a situation in which pin TXD is permanently forced to a LOW level, caused by a hardware and/or software application failure.

If the duration of the LOW level on pin TXD exceeds a certain time, the transmitter will be disabled. The timer will be reset by a HIGH level on pin TXD.

7.1 Failure detector

The failure detector is fully active in the normal operating mode. After the detection of a single bus failure the detector switches to the appropriate mode (see <u>Table 4</u>). The differential receiver threshold voltage is set at -3.2 V typical ($V_{CC} = 5$ V). This ensures correct reception with a noise margin as high as possible in the normal operating mode and in the event of failures 1, 2, 5 and 6a. These failures, or recovery from them, do not destroy ongoing transmissions. The output drivers remain active, the termination does not change and the receiver remains in differential mode (see <u>Table 4</u>).

Failures 3, 3a and 6 are detected by comparators connected to the CANH and CANL bus lines. Failures 3 and 3a are detected in a two-step approach. If the CANH bus line exceeds a certain voltage level, the differential comparator signals a continuous dominant condition. Because of inter operability reasons with the predecessor products PCA82C252 and TJA1053, after a first time-out the transceiver switches to single-wire operation through CANH. If the CANH bus line is still exceeding the CANH detection voltage for a second time-out, the TJA1054 switches to CANL operation; the CANH driver is switched off and the RTH bias changes to the pull-down current source. The time-outs (delays) are needed to avoid false triggering by external RF fields.

Fault-tolerant CAN transceiver

Table 4. Bus failures

Failure	Description	Termination CANH (RTH)	Termination CANL (RTL)	CANH driver	CANL driver	Receiver mode
1	CANH wire interrupted	on	on	on	on	differential
2	CANL wire interrupted	on	on	on	on	differential
3	CANH short-circuited to battery	weak[1]	on	off	on	CANL
3a	CANH short-circuited to V _{CC}	weak[1]	on	off	on	CANL
4	CANL short-circuited to ground	on	weak ^[2]	on	off	CANH
5	CANH short-circuited to ground	on	on	on	on	differential
6	CANL short-circuited to battery	on	weak[2]	on	off	CANH
6a	CANL short-circuited to V _{CC}	on	on	on	on	differential
7	CANL and CANH mutually short-circuited	on	weak[2]	on	off	CANH

^[1] A weak termination implies a pull-down current source behavior of 75 µA typical.

Failure 6 is detected if the CANL bus line exceeds its comparator threshold for a certain period of time. This delay is needed to avoid false triggering by external RF fields. After detection of failure 6, the reception is switched to the single-wire mode through CANH; the CANL driver is switched off and the RTL bias changes to the pull-up current source.

Recovery from failures 3, 3a and 6 is detected automatically after reading a consecutive recessive level by corresponding comparators for a certain period of time.

Failures 4 and 7 initially result in a permanent dominant level on pin RXD. After a time-out the CANL driver is switched off and the RTL bias changes to the pull-up current source. Reception continues by switching to the single-wire mode via pins CANH or CANL. When failures 4 or 7 are removed, the recessive bus levels are restored. If the differential voltage remains below the recessive threshold level for a certain period of time, reception and transmission switch back to the differential mode.

If any of the wiring failure occurs, the output signal on pin \overline{ERR} will be set to LOW. On error recovery, the output signal on pin \overline{ERR} will be set to HIGH again. In case of an interrupted open bus wire, this failure will be detected and signalled only if there is an open wire between the transmitting and receiving node(s). Thus, during open wire failures, pin \overline{ERR} typically toggles.

During all single-wire transmissions, EMC performance (both immunity and emission) is worse than in the differential mode. The integrated receiver filters suppress any HF noise induced into the bus wires. The cut-off frequency of these filters is a compromise between propagation delay and HF suppression. In single-wire mode, LF noise cannot be distinguished from the required signal.

^[2] A weak termination implies a pull-up current source behavior of 75 μ A typical.

Fault-tolerant CAN transceiver

7.2 Low power modes

The transceiver provides three low power modes which can be entered and exited via STB and EN (see Table 5 and Figure 3).

The sleep mode is the mode with the lowest power consumption. Pin INH is switched to HIGH-impedance for deactivation of the external voltage regulator. Pin CANL is biased to the battery voltage via pin RTL. If the supply voltage is provided, pins RXD and $\overline{\text{ERR}}$ will signal the wake-up interrupt.

The standby mode operates in the same way as the sleep mode but with a HIGH level on pin INH.

The power-on standby mode is the same as the standby mode, however, in this mode the battery power-on flag is shown on pin \overline{ERR} instead of the wake-up interrupt signal. The output on pin RXD will show the wake-up interrupt. This mode is only for reading out the power-on flag.

Table 5. Normal operating and low power modes

Mode	Pin STB	Pin EN	Pin ERR		Pin RXD		Pin RTL
			LOW	LOW HIGH		HIGH	switched to
Goto-sleep command	LOW	HIGH	wake-up interrupt		wake-up interrupt		V_{BAT}
Sleep	LOW	LOW[4]	signal[1][2][3]		signal[1][2][3]		
Standby	LOW	LOW					
Power-on standby	HIGH	LOW	V _{BAT} power-on flag ^{[1][5]}		wake-up interrupt signal[1][2][3]		V_{BAT}
Normal operating	HIGH	HIGH	error flag	no error flag	dominant received data	recessive received data	V _{CC}

^[1] If the supply voltage V_{CC} is present

Wake-up requests are recognized by the transceiver through two possible channels:

- The bus lines for remote wake-up
- Pin WAKE for local wake-up

In order to wake-up the transceiver remotely through the bus lines, a filter mechanism is integrated. This mechanism makes sure that noise and any present bus failure conditions do not result into an erroneous wake-up. Because of this mechanism it is not sufficient to simply pull the CANH or CANL bus lines to a dominant level for a certain time. To guarantee a successful remote wake-up under all conditions, a message frame with a dominant phase of at least the maximum specified $t_{(CANH)}$ or $t_{(CANL)}$ in it is required.

^[2] Wake-up interrupts are released when entering normal operating mode.

^[3] A local or remote wake-up event will be signalled at the transceiver pins RXD and $\overline{\text{ERR}}$ if $V_{BAT} = 5.3 \text{ V}$ to 27 V.

^[4] In case the goto-sleep command was used before. When V_{CC} drops, pin EN will become LOW, but due to the fail-safe functionality this does not effect the internal functions.

^[5] V_{BAT} power-on flag will be reset when entering normal operating mode.

Fault-tolerant CAN transceiver

A local wake-up through pin \overline{WAKE} is detected by a rising or falling edge with a consecutive level exceeding the maximum specified t_{WAKE} .

On a wake-up request the transceiver will set the output on pin INH to HIGH which can be used to activate the external supply voltage regulator.

If V_{CC} is provided the wake-up request can be read on the \overline{ERR} or RXD outputs, so the external microcontroller can activate the transceiver (switch to normal operating mode) via pins \overline{STB} and EN.

To prevent a false remote wake-up due to transients or RF fields, the wake-up voltage levels have to be maintained for a certain period of time. In the low power modes the failure detection circuit remains partly active to prevent an increased power consumption in the event of failures 3, 3a, 4 and 7.

To prevent a false local wake-up during an open wire at pin \overline{WAKE} , this pin has a weak pull-up current source towards V_{BAT} . However, in order to prevent EMC issues, it is recommended to connect a not used pin \overline{WAKE} to pin BAT. INH is set to floating only if the goto-sleep command is entered successfully. To enter a successful goto-sleep command under all conditions, this command must be kept stable for the maximum specified $t_{h(sleep)}$.

Pin INH will be set to a HIGH level again by the following events only:

- V_{BAT} power-on (cold start)
- Rising or falling edge on pin WAKE
- A message frame with a dominant phase of at least the maximum specified t_(CANH) or t_(CANL), while pin EN or pin STB is at a LOW level
- Pin STB goes to a HIGH level with V_{CC} active

To provide fail-safe functionality, the signals on pins $\overline{\text{STB}}$ and EN will internally be set to LOW when V_{CC} is below a certain threshold voltage $(V_{CC(stb)})$.

7.3 Power-on

After power-on (V_{BAT} switched on) the signal on pin INH will become HIGH and an internal power-on flag will be set. This flag can be read in the power-on standby mode through pin \overline{ERR} (\overline{STB} = 1; EN = 0) and will be reset by entering the normal operating mode.

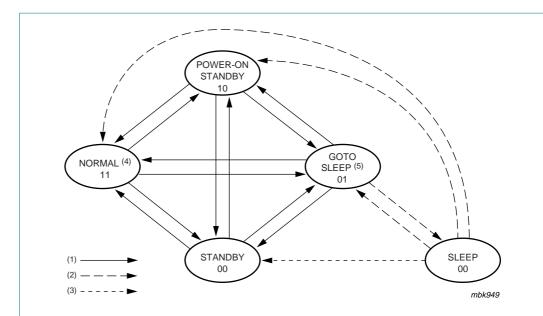
7.4 Protections

A current limiting circuit protects the transmitter output stages against short-circuit to positive and negative battery voltage.

If the junction temperature exceeds the typical value of 165 °C, the transmitter output stages are disabled. Because the transmitter is responsible for the major part of the power dissipation, this will result in a reduced power dissipation and hence a lower chip temperature. All other parts of the device will continue to operate.

The pins CANH and CANL are protected against electrical transients which may occur in an automotive environment.

Fault-tolerant CAN transceiver



Mode 10 stands for: Pin \overline{STB} = HIGH and pin EN = LOW.

- (1) Mode change via input pins STB and EN.
- (2) Mode change via input pins STB and EN; it should be noted that in the sleep mode pin INH is inactive and possibly there is no V_{CC}. Mode control is only possible if V_{CC} of the transceiver is active.
- (3) Pin INH is activated after wake-up via bus input pin WAKE.
- (4) Transitions to normal mode clear the internal wake-up: interrupt and battery fail flag are
- (5) Transitions to sleep mode: pin INH is deactivated.

Fig 3. Mode control

8. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).[1]

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.3	+6	V
V_{BAT}	battery supply voltage		-0.3	+40	V
V_{TXD}	voltage on pin TXD		-0.3	$V_{CC} + 0.3$	V
V_{RXD}	voltage on pin RXD		-0.3	$V_{CC} + 0.3$	V
V_{ERR}	voltage on pin \overline{ERR}		-0.3	$V_{CC} + 0.3$	V
V_{STB}	voltage on pin STB		-0.3	$V_{CC} + 0.3$	V
V_{EN}	voltage on pin EN		-0.3	$V_{CC} + 0.3$	V
V_{CANH}	voltage on pin CANH	with respect to any other pin	-40	+40	V
V _{CANL}	voltage on pin CANL	with respect to any other pin	-40	+40	V
V _{trt(n)}	transient voltage on pins CANH and CANL	see Figure 6	-150	+100	V

Fault-tolerant CAN transceiver

Table 6. Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).[1]

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{I(WAKE)}$	input voltage on pin WAKE	with respect to any other pin	-	V _{BAT} + 0.3	V
I _{I(WAKE)}	input current on pin WAKE		^[2] –15	-	mA
V_{INH}	voltage on pin INH		-0.3	$V_{BAT} + 0.3$	V
V_{RTH}	voltage on pin RTH	with respect to any other pin	-0.3	V _{BAT} + 1.2	V
V_{RTL}	voltage on pin RTL	with respect to any other pin	-0.3	V _{BAT} + 1.2	V
R _{RTH}	termination resistance on pin RTH		500	16000	Ω
R _{RTL}	termination resistance on pin RTL		500	16000	Ω
T_{vj}	virtual junction temperature		<u>[3]</u> –40	+150	°C
T _{stg}	storage temperature		-55	+150	°C
V _{ESD}	electrostatic discharge	human body model	<u>[4]</u> –2	+2	kV
	voltage	machine model	[<u>5</u>] -100	+100	V

^[1] All voltages are defined with respect to pin GND, unless otherwise specified. Positive current flows into the device.

9. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	120	K/W
$R_{th(j-s)}$	thermal resistance from junction to substrate bare die	in free air	40	K/W

^[2] Only relevant if $V_{WAKE} < V_{GND} - 0.3 V$; current will flow into pin GND.

^[3] Junction temperature in accordance with "IEC 60747-1". An alternative definition is: $T_{vj} = T_{amb} + P \times R_{th(vj-a)}$ where $R_{th(vj-a)}$ is a fixed value to be used for the calculation of T_{vj} . The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}) .

^[4] Equivalent to discharging a 100 pF capacitor through a 1.5 k Ω resistor.

^[5] Equivalent to discharging a 200 pF capacitor through a 10 Ω resistor and a 0.75 μ H coil.

Fault-tolerant CAN transceiver

10. Static characteristics

 Table 8.
 Static characteristics

 $V_{CC} = 4.75 \text{ V}$ to 5.25 V; $V_{BAT} = 5.0 \text{ V}$ to 27 V; $V_{STB} = V_{CC}$; $T_{vj} = -40 \,^{\circ}\text{C}$ to +150 $^{\circ}\text{C}$; all voltages are defined with respect to ground; positive currents flow into the device; unless otherwise specified. [1][2][3]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
-	oins V _{CC} and BAT)			- •		
V _{CC}	supply voltage		4.75	-	5.25	V
V _{CC(stb)}	supply voltage for forced standby mode (fail-safe)		2.75	-	4.5	V
I _{CC}	supply current	normal operating mode; V _{TXD} = V _{CC} (recessive)	4	7	11	mA
		normal operating mode; V _{TXD} = 0 V (dominant); no load	10	17	27	mA
		low power modes at $V_{TXD} = V_{CC}$	0	0	10	μΑ
V_{BAT}	battery supply voltage	no time limit	-0.3	-	+40	V
	on pin BAT	operating mode	5.0	-	27	V
		load dump	-	-	40	V
I _{BAT}	battery supply current on pin BAT	all modes and in low power modes at				
		$V_{RTL} = V_{WAKE} = V_{INH} = V_{BAT}$				
		$V_{BAT} = 12 V$	10	30	50	μΑ
		$V_{BAT} = 5 V \text{ to } 27 V$	5	30	125	μΑ
		$V_{BAT} = 3.5 V$	5	20	30	μΑ
		V _{BAT} = 1 V	0	0	10	μΑ
		sleep mode; V _{CC} = 0 V;				
		V _{BAT} = 12 V	-	30	50	μΑ
V _{BAT(Pwon)}	power-on flag voltage	low power modes				
	on pin BAT	power-on flag set	-	-	1	V
		power-on flag not set	3.5	-	-	V
I _{tot}	supply current plus battery current	low power modes; $V_{CC} = 5 \text{ V}$; $V_{BAT} = V_{WAKE} = V_{INH} = 12 \text{ V}$	-	30	60	μΑ
Pins STB, I	EN and TXD					
V _{IH}	HIGH-level input voltage		$0.7V_{CC}$	-	V _{CC} +0.3	V
V _{IL}	LOW-level input voltage		-0.3	-	$0.3V_{CC}$	V
I _{IH}	HIGH-level input current					
	pins STB and EN	$V_I = 4 V$	-	9	20	μΑ
	pin TXD	$V_I = 4 V$	-200	-80	-25	μΑ
I _{IL}	LOW-level input current					
	pins STB and EN	V _I = 1 V	4	8	-	μΑ
	pin TXD	V _I = 1 V	-800	-320	-100	μΑ

Fault-tolerant CAN transceiver

 Table 8.
 Static characteristics ...continued

 $V_{CC} = 4.75 \text{ V}$ to 5.25 V; $V_{BAT} = 5.0 \text{ V}$ to 27 V; $V_{STB} = V_{CC}$; $T_{vj} = -40 \,^{\circ}\text{C}$ to +150 $^{\circ}\text{C}$; all voltages are defined with respect to ground; positive currents flow into the device; unless otherwise specified. [1][2][3]

Symbol	Parameter	Conditions	Min	Тур	Max	Uni
Pins RXD	and ERR					
V _{OH)}	HIGH-level output voltage					
	on pin ERR	$I_{O} = -100 \mu A$	$V_{CC}-0.9$	-	V_{CC}	V
	on pin RXD	$I_O = -1 \text{ mA}$	$V_{CC}-0.9$	-	V_{CC}	V
V_{OL}	LOW-level output voltage					
	on pin ERR	I _O = 1.6 mA	0	-	0.4	V
	on pin RXD	I _O = 7.5 mA	0	-	1.5	V
Pin WAKE						
I _{IL}	LOW-level input current	$V_{WAKE} = 0 V; V_{BAT} = 27 V$	-10	-4	-1	μΑ
$V_{th(wake)}$	wake-up threshold voltage	$V_{STB} = 0 V$	2.5	3.2	3.9	V
Pin INH						
ΔV_{H}	HIGH-level voltage drop	$I_{INH} = -0.18 \text{ mA}$	-	-	0.8	V
IL	leakage current	sleep mode; V _{INH} = 0 V	-	-	5	μΑ
Pins CANH	d and CANL					
V _{CANH}	voltage on pin CANH	$V_{CC} = 0 \text{ V to } 5.0 \text{ V}; V_{BAT} \ge 0 \text{ V};$ no time limit; with respect to any other pin	-40	-	+40	V
V_{CANL}	voltage on pin CANL	$V_{CC} = 0 \text{ V to } 5.0 \text{ V; } V_{BAT} \ge 0 \text{ V;}$ no time limit; with respect to any other pin	-40	-	+40	V
ΔV_{CANH}	voltage drop on pin CANH	$I_{CANH} = -40 \text{ mA}$	-	-	1.4	V
ΔV_{CANL}	voltage drop on pin CANL	I _{CANL} = 40 mA	-	-	1.4	V
$V_{th(dif)}$	differential receiver threshold voltage	no failures and bus failures 1, 2, 5 and 6a; see <u>Figure 4</u>				
		V _{CC} = 5 V	-3.5	-3.2	-2.9	V
		V _{CC} = 4.75 V to 5.25 V	-0.70V _{CC}	-0.64V _{CC}	-0.58V _{CC}	V
V _{O(reces)}	recessive output voltage	$V_{TXD} = V_{CC}$				
	on pin CANH	$R_{RTH} < 4 \text{ k}\Omega$	-	-	0.2	V
	on pin CANL	$R_{RTL} < 4 k\Omega$	$V_{CC}-0.2$	-	-	V
V _{O(dom)}	dominant output voltage	$V_{TXD} = 0 \text{ V}; V_{EN} = V_{CC}$				
	on pin CANH	$I_{CANH} = -40 \text{ mA}$	V _{CC} – 1.4	-	-	V
	on pin CANL	I _{CANL} = 40 mA	-	-	1.4	V
I _{O(CANH)}	output current on pin CANH	normal operating mode; V _{CANH} = 0 V; V _{TXD} = 0 V	-110	-80	-45	mΑ
		low power modes; V _{CANH} = 0 V; V _{CC} = 5 V	-	-0.25	-	μΑ

Fault-tolerant CAN transceiver

 Table 8.
 Static characteristics ...continued

 $V_{CC} = 4.75 \text{ V}$ to 5.25 V; $V_{BAT} = 5.0 \text{ V}$ to 27 V; $V_{STB} = V_{CC}$; $T_{vj} = -40 \,^{\circ}\text{C}$ to +150 $^{\circ}\text{C}$; all voltages are defined with respect to ground; positive currents flow into the device; unless otherwise specified. [1][2][3]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{O(CANL)}	output current on pin CANL	normal operating mode; $V_{CANL} = 14 \text{ V}; V_{TXD} = 0 \text{ V}$	45	70	100	mA
		low power modes; $V_{CANL} = 12 \text{ V}; V_{BAT} = 12 \text{ V}$	-	0	-	μΑ
V _{d(CANH)(sc)}	detection voltage for short-circuit to battery	normal operating mode; $V_{CC} = 5 \text{ V}$	1.5	1.7	1.85	V
	voltage on pin CANH	low power modes	1.1	1.8	2.5	V
V _{d(CANL)(sc)}	detection voltage for	normal operating mode				
	short-circuit to battery voltage on pin CANL	$V_{CC} = 5 V$	6.6	7.2	7.8	V
	Voltage on pin ortive	$V_{CC} = 4.75 \text{ V to } 5.25 \text{ V}$	$1.32V_{CC}$	1.44V _{CC}	1.56V _{CC}	V
$V_{th(wake)}$	wake-up threshold voltage					
	on pin CANL	low power modes	2.5	3.2	3.9	V
	on pin CANH	low power modes	1.1	1.8	2.5	V
$\Delta V_{th(wake)}$	difference of wake-up threshold voltages	low power modes	0.8	1.4	-	V
V _{th(CANH)(sc)}	single-ended receiver threshold voltage on pin CANH	normal operating mode and failures 4, 6 and 7				
		$V_{CC} = 5 V$	1.5	1.7	1.85	V
		$V_{CC} = 4.75 \text{ V to } 5.25 \text{ V}$	0.30V _{CC}	0.34V _{CC}	0.37V _{CC}	V
$V_{th(CANL)(sc)}$	single-ended receiver threshold voltage on pin CANL	normal operating mode and failures 3 and 3a				
		V _{CC} = 5 V	3.15	3.3	3.45	V
		V _{CC} = 4.75 V to 5.25 V	0.63V _{CC}	0.66V _{CC}	0.69V _{CC}	V
$R_{i(CANH)(sc)} \\$	single-ended input resistance on pin CANH	normal operating mode	110	165	270	kΩ
R _{i(CANL)(sc)}	single-ended input resistance on pin CANL	normal operating mode	110	165	270	kΩ
$R_{i(dif)}$	differential input resistance	normal operating mode	220	330	540	kΩ
Pins RTH ar	nd RTL					
$R_{sw(RTL)}$	switch-on resistance on pin RTL and V _{CC}	normal operating mode; I _O < 10 mA	-	50	100	Ω
$R_{\text{sw}(\text{RTH})}$	switch-on resistance on pin RTH and ground	normal operating mode; I _O < 10 mA	-	50	100	Ω
V _{O(RTH)}	output voltage on pin RTH	low power modes; I _O = 1 mA	-	0.7	1.0	V
I _{O(RTL)}	output current on pin RTL	low power modes; $V_{RTL} = 0 V$	-1.25	-0.65	-0.3	mA
$I_{pu(RTL)}$	pull-up current on pin RTL	normal operating mode and failures 4, 6 and 7	-	75	-	μΑ

TJA1054 NXP Semiconductors

Fault-tolerant CAN transceiver

Static characteristics ... continued

 V_{CC} = 4.75 V to 5.25 V; V_{BAT} = 5.0 V to 27 V; V_{STB} = V_{CC} ; T_{vj} = -40 °C to +150 °C; all voltages are defined with respect to ground; positive currents flow into the device; unless otherwise specified. [1][2][3]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$I_{pd(RTH)}$	pull-down current on pin RTH	normal operating mode and failures 3 and 3a	-	75	-	μΑ
Thermal sl	nutdown					
$T_{j(sd)}$	shutdown junction temperature		155	165	180	°C

All parameters are guaranteed over the virtual junction temperature range by design, but only 100 % tested at T_{amb} = 125 °C for dies on wafer level, and above this for cased products 100 % tested at T_{amb} = 25 °C, unless otherwise specified.

11. Dynamic characteristics

Dynamic characteristics

 V_{CC} = 4.75 V to 5.25 V; V_{BAT} = 5.0 V to 27 V; V_{STB} = V_{CC} ; T_{vj} = -40 °C to +150 °C; all voltages are defined with respect to ground; unless otherwise specified.[1][2][3]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$t_{t(r-d)}$	transition time for recessive to dominant (on pins CANL and CANH)	between 10 % and 90 %; R1 = 100 Ω ; C1 = 10 nF; C2 = not present; see Figure 5		0.65	-	μs
$t_{t(d-r))}$	transition time for dominant to recessive (on pins CANL and CANH)	between 10 % and 90 %; R1 = 100 Ω ; C1 = 10 nF; C2 = not present; see Figure 5	0.2	0.3	-	μs
t _{PD(L)}	propagation delay TXD (LOW) to RXD (LOW)	no failures and failures 1, 2, 5 and 6a; R1 = 100 Ω ; see Figure 4 and Figure 5				
		C1 = 1 nF; C2 = not present	-	0.75	1.5	μs
		C1 = C2 = 3.3 nF	-	1	1.75	μs
		failures 3, 3a, 4, 6 and 7; R1 = 100 Ω ; see Figure 4 and Figure 5				
		C1 = 1 nF; C2 = not present	-	0.85	1.4	μs
		C1 = C2 = 3.3 nF	-	1.1	1.7	μs
t _{PD(H)}	propagation delay TXD (HIGH) to RXD (HIGH)	no failures and failures 1, 2, 5 and 6a; R1 = 100 Ω ; see Figure 4 and Figure 5				
		C1 = 1 nF; C2 = not present	-	1.2	1.9	μs
		C1 = C2 = 3.3 nF	-	2.5	3.3	μs
		failures 3, 3a, 4, 6 and 7; R1 = 100 Ω ; see Figure 4 and Figure 5				
		C1 = 1 nF; C2 = not present	-	1.1	1.7	μs
		C1 = C2 = 3.3 nF	-	1.5	2.2	μs
t _r	bus line output rise time	between 10 % and 90 %; C1 = 10 nF; see Figure 5	-	0.6	-	μs
t _f	bus line output fall time	between 10 % and 90 %; C1 = 1 nF; see Figure 5	-	0.3	-	μs
t _{react(sleep)}	reaction time of goto sleep command		<u>[4]</u> 5	-	50	μs
ΓJA1054_4					© NXP B.V. 2009.	All rights reserve

^[2] For bare die, all parameters are only guaranteed if the back side of the die is connected to ground.

A local or remote wake-up event will be signalled at the transceiver pins RXD and ERR if V_{BAT} = 5.3 V to 27 V (see Table 5).

Fault-tolerant CAN transceiver

 Table 9.
 Dynamic characteristics ...continued

 $V_{CC} = 4.75 \text{ V}$ to 5.25 V; $V_{BAT} = 5.0 \text{ V}$ to 27 V; $V_{STB} = V_{CC}$; $T_{vj} = -40 \,^{\circ}\text{C}$ to +150 $^{\circ}\text{C}$; all voltages are defined with respect to ground; unless otherwise specified. [1][2][3]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$t_{\text{dis}(TxD)}$	disable time of TxD permanent dominant timer	normal operating mode; $V_{TXD} = 0 V$		0.75	-	4	ms
t _{CANH}	dominant time for remote wake-up on pin CANH	low power modes; $V_{BAT} = 12 \text{ V}$			-	38	μs
t _{CANL}	dominant time for remote wake-up on pin CANL	ow power modes; $V_{BAT} = 12 \text{ V}$ [4]		7	-	38	μs
t _{WAKE}	required time on pin WAKE for local wake-up	low power modes; $V_{BAT} = 12 \text{ V}$; for wake-up after receiving a falling or rising edge	vake-up after receiving a falling or		-	38	μs
t _{det}	failure detection time	normal operating mode					
		failures 3 and 3a		1.6	-	8.0	ms
		failures 4, 6 and 7		0.3	-	1.6	ms
		low power modes; V _{BAT} = 12 V					
		failures 3 and 3a		1.6	-	8.0	ms
		failures 4 and 7		0.1	-	1.6	ms
t _{rec}	failure recovery time	normal operating mode					
		failures 3 and 3a		0.3	-	1.6	ms
		failures 4 and 7		7	-	38	μs
		failure 6		125	-	750	μs
		low power modes; V _{BAT} = 12 V					
		failures 3, 3a, 4 and 7		0.3	-	1.6	ms
n _{det}	pulse-count difference between CANH and CANL for failure detection	normal operating mode and failures 1, 2, 5 and 6a; pin ERR becomes LOW		-	4	-	
n _{rec}	number of consecutive pulses on CANH and CANL simultaneously for failure recovery	failures 1, 2, 5 and 6a		-	4	-	

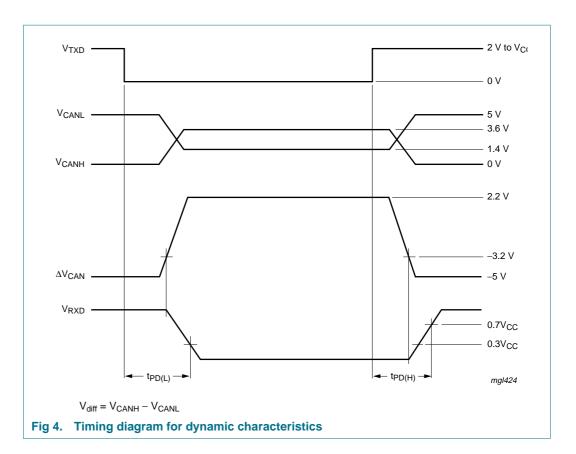
^[1] All parameters are guaranteed over the virtual junction temperature range by design, but only 100 % tested at T_{amb} = 125 °C for dies on wafer level, and above this for cased products 100 % tested at T_{amb} = 25 °C, unless otherwise specified.

^[2] For bare die, all parameters are only guaranteed if the back side of the die is connected to ground.

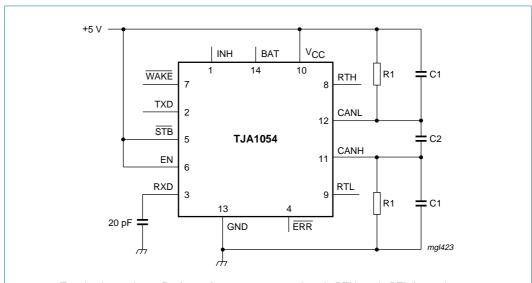
^[3] A local or remote wake-up event will be signalled at the transceiver pins RXD and ERR if V_{BAT} = 5.3 V to 27 V (see Table 5).

^[4] To guarantee a successful mode transition under all conditions, the maximum specified time must be applied.

Fault-tolerant CAN transceiver



12. Test information

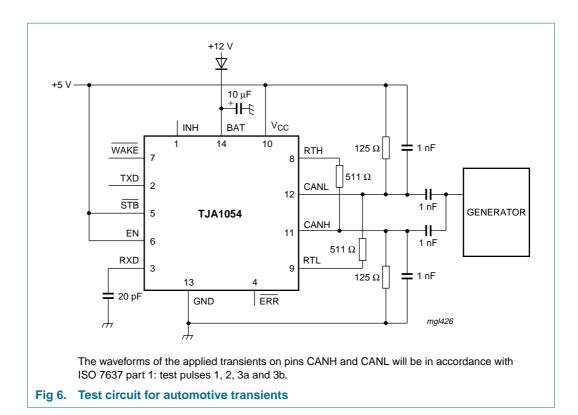


Termination resistors R1 (100 Ω) are not connected to pin RTH or pin RTL for testing purposes because the minimum load allowed on the CAN bus lines is 500 Ω per transceiver.

The capacitive bus load of 10 nF is split into 3 equal capacitors (3.3 nF) to simulate the bus cable.

Fig 5. Test circuit for dynamic characteristics

Fault-tolerant CAN transceiver



 V_{BAT} BATTERY V_{DD} +5 V P8xC592/P8xCE598 CAN CONTROLLER +5 V CTX0 CRXO Px.x Px.x Px.x TXD ERR INH RXD STB ΕN 2 3 5 1 WAKE BAT 14 Vcc **TJA1054** 10 CAN TRANSCEIVER 100 nF GND 13 12 9 CANH CANL RTL RTH CAN BUS LINE mgl425 Fig 7. Application diagram

12.1 Quality information

This product has been qualified to the appropriate Automotive Electronics Council (AEC) standard Q100 or Q101 and is suitable for use in automotive applications.

TJA1054_4 © NXP B.V. 2009. All rights reserved.

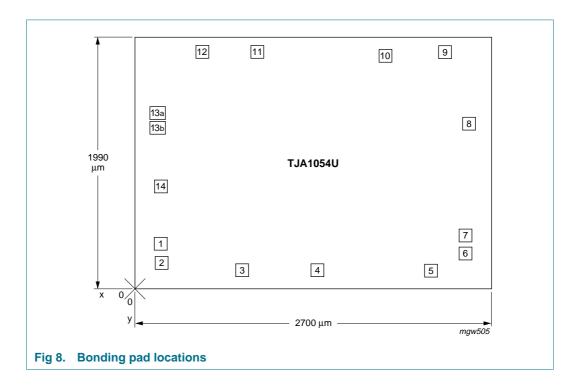
Fault-tolerant CAN transceiver

13. Bare die information

Table 10. Bonding pad locations

Symbol	Pad	Coordinates ^[1]	Coordinates ^[1]			
		x	у			
INH	1	106	317			
TXD	2	111	169			
RXD	3	750	111			
ERR	4	1347	111			
STB	5	2248	103			
EN	6	2521	240			
WAKE	7	2521	381			
RTH	8	2550	1269			
RTL	9	2359	1840			
V _{CC}	10	1886	1809			
CANH	11	872	1840			
CANL	12	437	1840			
GND	13a	80	1356			
GND	13b	80	1241			
BAT	14	106	772			

^[1] All coordinates (μ m) represent the position of the center of each pad with respect to the bottom left-hand corner of the top aluminium layer (see Figure 8).

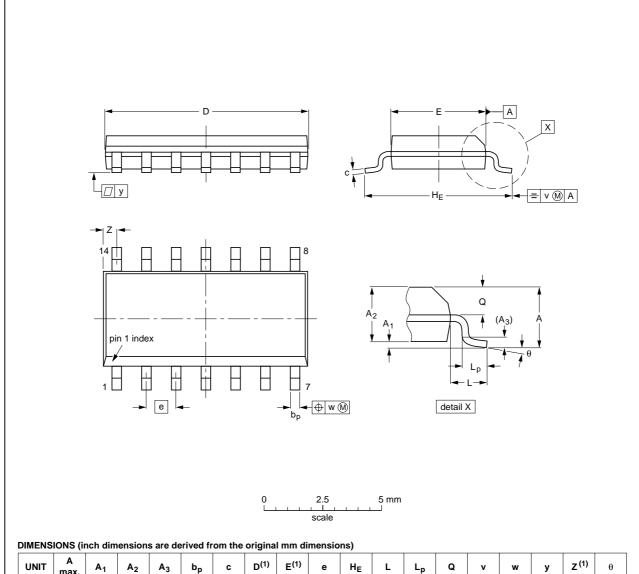


Fault-tolerant CAN transceiver

14. Package outline

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01	1	0.0100 0.0075	0.35 0.34	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLIN	E		REFER	EUROPEAN	ISSUE DATE		
VERSION		IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT108	i-1	076E06	MS-012				99-12-27 03-02-19

Fig 9. Package outline SOT108-1 (SO14)

IA1054_4 © NXP B.V. 2009. All rights reserved.

Fault-tolerant CAN transceiver

15. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

15.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

15.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- · Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

15.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

TJA1054_4 © NXP B.V. 2009. All rights reserved.

Fault-tolerant CAN transceiver

15.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 10</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 11 and 12

Table 11. SnPb eutectic process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C)				
	Volume (mm³)				
	< 350	≥ 350			
< 2.5	235	220			
≥ 2.5	220	220			

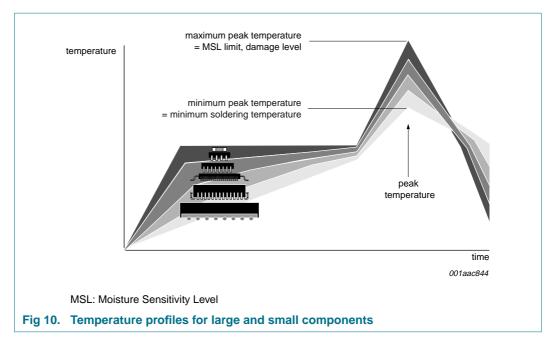
Table 12. Lead-free process (from J-STD-020C)

Package thickness (mm) Package reflow temperature (°C)							
	Volume (mm ³)	Volume (mm³)					
	< 350	350 to 2000	> 2000				
< 1.6	260	260	260				
1.6 to 2.5	260	250	245				
> 2.5	250	245	245				

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 10.

Fault-tolerant CAN transceiver



For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

16. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes			
TJA1054_4	20090924	Product data sheet	-	TJA1054_3			
Modifications:		f this data sheet has been red NXP Semiconductors.	esigned to comply w	ith the new identity			
	 Legal texts h 	ave been adapted to the new	company name whe	re appropriate.			
 Value of parameter V_{ESD} (machine model) changed in <u>Table 6</u>. 							
TJA1054_3 (9397 750 11721)	20040323	Product specification	-	TJA1054_2			
TJA1054_2 (9397 750 08965)	20011120	Product specification	-	TJA1054_1			
TJA1054_1 (9397 750 03636)	19990211	Preliminary specification	-	-			

Fault-tolerant CAN transceiver

17. Legal information

17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

17.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

17.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

Bare die — All die are tested on compliance with their related technical specifications as stated in this data sheet up to the point of wafer sawing and are handled in accordance with the NXP Semiconductors storage and transportation conditions. If there are data sheet limits not guaranteed, these will be separately indicated in the data sheet. There are no post-packing tests performed on individual die or wafers.

NXP Semiconductors has no control of third party procedures in the sawing, handling, packing or assembly of the die. Accordingly, NXP Semiconductors assumes no liability for device functionality or performance of the die or systems after third party sawing, handling, packing or assembly of the die. It is the responsibility of the customer to test and qualify their application in which the die is used.

All die sales are conditioned upon and subject to the customer entering into a written die sale agreement with NXP Semiconductors through its legal department.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

17.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

TJA1054_4 © NXP B.V. 2009. All rights reserved.

Fault-tolerant CAN transceiver

18. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

Fault-tolerant CAN transceiver

19. Contents

1	General description
2	Features
2.1	Optimized for in-car low-speed communication 1
2.2	Bus failure management1
2.3	Protections
2.4	Support for low power modes 2
3	Quick reference data
4	Ordering information
5	Block diagram 3
6	Pinning information 4
6.1	Pinning 4
6.2	Pin description 4
7	Functional description 5
7.1	Failure detector5
7.2	Low power modes 7
7.3	Power-on
7.4	Protections
8	Limiting values9
9	Thermal characteristics 10
10	Static characteristics11
11	Dynamic characteristics
12	Test information
12.1	Quality information
13	Bare die information
14	Package outline
15	Soldering of SMD packages 20
15.1	Introduction to soldering
15.2	Wave and reflow soldering
15.3	Wave soldering
15.4	Reflow soldering 21
16	Revision history
17	Legal information
17.1	Data sheet status 23
17.2	Definitions
17.3	Disclaimers
17.4	Trademarks23
18	Contact information 24
19	Contents

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.





Home About NXP News Careers Investors Order/buy Support Contact my.NXP

Type search here Search Advanced search / Selection guides

English

Select site:

Applications

See also

Fault-tolerant CAN transceivers TJA1054T

TJA1054

Preview Product information i

Selection guide @

Looking for

Datasheet

TJA1054 (Product Specification) 24-Sep-09, 25 Pages, 138kB

Download datasheet Download all documentation TJA1054 - Fault-tolerant CAN transceiver

All information hereunder is subject to the subsequent disclaimers

General description Products/packages Quality/reliability/chemical Pricing/ordering/availability Samples Discontinued information Applications
Block diagrams/pinning

Design support Parametrics/similar products Print/email Disclaimers

See the answers to FAQ's on certain fields of interest

Find NXP's equivalent of a competitor's part number

View case studies on general applications or technologies

Request contact with a technical expert Find more information on NXP's Vision Find out more about our ordering process

Receive e-news on specific interest areas

General description

Hide

The TJA1054 is the interface between the protocol controller and the physical bus wires in a Controller Area Network (CAN). It is primarily intended for low-speed applications up to 125 kBd in passenger cars. The device provides differential receive and transmit capability but will switch to single-wire transmitter and/or receiver in error conditions.

The TJA1054T is pin and downwards compatible with the PCA82C252T and the TJA1053T. This means that these two devices can be replaced by the TJA1054T with retention of all functions.

The most important improvements of the TJA1054 with respect to the PCA82C252 and TJA1053 are:

Very low EME due to a very good matching of the CANL and CANH output signals

Good EMI, especially in low power modes
Full wake-up capability during bus failures
Extended bus failure management including short-circuit of the CANH bus line to V_{CC}

Support for easy system fault diagnosis

Two-edge sensitive wake-up input signal via pin WAKE

Back to top

Features Hide

Optimized for in-car low-speed communication Baud rate up to 125 kBd

Up to 32 nodes can be connected Supports unshielded bus wires

Very low ElectroMagnetic Emission (EME) due to built-in slope control function and a very good matching of the CANL and CANH bus outputs Very high ElectroMagnetic Immunity (EMI) in normal and low power operating modes

Fully integrated receiver filters

Transmit Data (TxD) dominant time-out function

Bus failure management

Supports single-wire transmission modes with ground offset voltages up to 1.5 V

Automatic switching to single-wire mode in the event of bus failures, even when the CANH bus wire is short-circuited to V_{CC}

Automatic reset to differential mode if bus failure is removed

Full wake-up capability during failure modes

Protections

Bus pins short-circuit safe to battery and to ground

Thermally protected
Bus lines protected against transients in an automotive environment

An unpowered node does not disturb the bus lines

Support for low power modes

Low current sleep mode and standby mode with wake-up via the bus lines

Power-on reset flag on the output

Back to top

Products/packages

Hide	

Type number	Orderable part number	Ordering code (12NC)	Product status	Package	Packing	Marking	ECCN
TJA1054T/S900/VM	TJA1054T/S900/VM:5	9352 879 79512	Volume production	SOT108	Tube Dry Pack	Standard Marking	
TJA1054T/S900/VM	TJA1054T/S900/VM,5	9352 879 79518	Volume production	SOT108	Reel Dry Pack, SMD, 13"	Standard Marking	
TJA1054T/VM	TJA1054T/VM,512	9352 879 81512	Volume production	SOT108	Tube Dry Pack	Standard Marking	
TJA1054T/VM	TJA1054T/VM,518	9352 879 81518	Volume production	SOT108	Reel Dry Pack, SMD, 13"	Standard Marking	

The variants in the table below are discontinued. See the table Discontinued information for more information.

Type number	Orderable part number	Ordering code (12NC)	Product status	Package	Packing	Marking	ECCN
TJA1054T/N1	TJA1054T/N1,512	9352 615 12512	Discontinued Replacement product	SOT108	Tube Dry Pack	Standard Marking	
TJA1054T/N1	TJA1054T/N1,518	9352 615 12518	Discontinued Replacement product	SOT108	Reel Dry Pack, SMD, 13"	Standard Marking	
TJA1054T/S900	TJA1054T/S900,512	9352 832 38512	Discontinued Replacement product	SOT108	Tube Dry Pack	Standard Marking	
TJA1054T/S900	TJA1054T/S900,518	9352 832 38518	Discontinued Replacement product	SOT108	Reel Dry Pack, SMD, 13"	Standard Marking	
TJA1054U/N1	TJA1054U/N1,005	9352 615 11005	Discontinued Replacement product	Uncased die	Chips on Wafer, Pre-Sawn, On FFC	No Marking	
TJA1054U/N1	TJA1054U/N1,027	9352 615 11027	Discontinued Replacement product	Uncased die	Circuit Element Packed On Reel 7"	No Marking	

23-Oct-2009 http://www.nxp.com/

Back to top

Quality/reliability/chemical content

Type number	Orderable part number	Chemical content	RoHS	Leadfree conversion date	RHF	IFR (FIT)	MTBF (hours)	MSL
TJA1054T/S900/VM	TJA1054T/S900/VM:5	TJA1054T_S900_VM	EU/CN RoHs COMPLIANT E	Always Pb-free	D			
TJA1054T/S900/VM	TJA1054T/S900/VM,5	TJA1054T_S900_VM	EU/CN RoH: COMPLIANT D	Always Pb-free	D			
TJA1054T/VM	TJA1054T/VM,512	TJA1054T_VM	EU/CN ROHS COMPLIANT E PD	Always Pb-free	D			
TJA1054T/VM	TJA1054T/VM,518	TJA1054T_VM	EU/CN RoH2 COMPLIANT D	Always Pb-free	D			

The variants in the table below are discontinued. See the table Discontinued information for more information.

Type number	Orderable part number	Chemical content	RoHS	Leadfree conversion date	RHF	IFR (FIT)	MTBF (hours)	MSL
TJA1054T/N1	TJA1054T/N1,512	TJA1054T_N1	EU/ON ROHE COMPLIANT 3	Always Pb-free	G			
TJA1054T/N1	TJA1054T/N1,518	TJA1054T_N1	EU/CN ROHZ COMPLIANT 🗵 🔞	Always Pb-free	G			
TJA1054T/S900	TJA1054T/S900,512	Not available	EU/ON ROHECOMPLIANT E	Always Pb-free	G			
TJA1054T/S900	TJA1054T/S900,518	Not available	EU/CN ROHECOMPLIANT E	Always Pb-free	G			
TJA1054U/N1	TJA1054U/N1,005	TJA1054U_N1	EU ROHECOMPLIANT [7]		Е			
TJA1054U/N1	TJA1054U/N1,027	TJA1054U_N1	EU ROHECOMPLIANT D		E			

Quality and reliability disclaimer

Back to top

Pricing/ordering/availability

Hide

Type number	Ordering code (12NC)	Orderable part number	Indicative price/unit(\$)	Region	Distributor	In stock	Order quantity	Inventory date	Buy online	Samples
TJA1054T/S900/VM	9352 879 79512	TJA1054T/S900/VM:5								not available
TJA1054T/S900/VM	9352 879 79518	TJA1054T/S900/VM,5								Order samples
TJA1054T/VM	9352 879 81512	TJA1054T/VM,512		NA	FUTURE ELECTRONICS	1,140		10/21/2009	Buy online	not available
TJA1054T/VM	9352 879 81518	TJA1054T/VM,518		NA	FUTURE ELECTRONICS	2,500		10/21/2009	Buy online	Order samples

Back to top

Discontinued information

Hide

Type number	Ordering code (12NC)	Last- time buy date	Last-time delivery date	Replacement product	DN Notice	Status	Comments
TJA1054T/N1	935261512512	31-dec- 09	31-mrt-11	TJA1054T/VM	DN 64	Sole source product Limited availability (check with your usual sales contact)	FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009. Extended Last Time Delivery till 31.3.2011. Replacement type with new diffusion fab location only
TJA1054T/N1	935261512518	31-dec- 09	31-mrt-11	TJA1054T/VM	DN 64	Sole source product Limited availability (check with your usual sales contact)	FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009. Extended Last Time Delivery till 31.3.2011. Replacement type with new diffusion fab location only
TJA1054T/S900	935283238512	31-dec- 09	31-mrt-11	TJA1054T/S900VM	DN 64	Sole source product Limited availability (check with your usual sales contact)	FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009. Extended Last Time Delivery till 31.3.2011. Replacement type with new diffusion fab location only
TJA1054T/S900	935283238518	31-dec- 09	31-mrt-11	TJA1054T/S900VM	DN 64	Sole source product Limited availability (check with your usual sales contact)	FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009. Extended Last Time Delivery till 31.3.2011. Replacement type with new diffusion fab location only
TJA1054U/N1	935261511005	31-dec- 09	30-jun-10	none	DN 64	Sole source product Limited availability (check with your usual sales contact) Type number fully withdrawn	Limited Availability. FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009.
TJA1054U/N1	935261511027	31-dec- 09	30-jun-10	none	DN 64	Sole source product Limited availability (check with your usual sales contact) Type number fully withdrawn	Limited Availability. FAB ICN5 Closure. Refer to PCN200901054A dated January 21, 2009.

Back to top

Design support

Application Notes

AH_FTCAN3_1;Fault-tolerant CAN Transceiver (2001-12-20)

AH_FTCAN3_1;Fault-tolerant CAN Transceiver (2001-12-20)

AN00094_3;TJA1041/1041A high speed CAN transceiver (2006-11-08)

Support Documents
75016161; NXP Automotive networking solutions (2007-09-01)
75015743; Proven performance ensures automotive applications can always communicate (2006-09-01)
75015741; The vital link in the interconnected car (2006-09-01)

Back to top

http://www.nxp.com/ 23-Oct-2009 Parametrics/similar products

Hide

Type number	Package	Supply voltage (V)	Application	Configuration	CATEGORY	FEATURES	FUNCTION	Operating temp. (Cel)	No. of Pins	Package Material	Transceiver Type
TJA1054T/N1	SOT108	5	Control Devices	FT-CAN	transceiver	ISO11898-3 compliant	Transceivers	-40 ~ +125	14	SO14	Fault-Tolerant CAN Transceivers
TJA1054U/N1	Uncased die	5	Control Devices	FT-CAN	transceiver	ISO11898-3 compliant	Transceivers	-40 ~ +125	14	SO14	Fault-Tolerant CAN Transceivers

Similar products

TJA1054 links to the similar products page containing an overview of products that are similar in function or related to the type number(s) as listed on this page. The similar products page includes products from the same catalog tree(s), relevant selection guides and products from the same functional category.

Back to top

Print/email

Email this product information Print this product information

Back to top

Disclaimers Hide

General product disclaimer Quality and reliability disclaimer

NXP | Privacy policy | Terms of use | Sitemap | Switch to classic mode

©2006-2009 NXP Semiconductors. All rights reserved.

23-Oct-2009 http://www.nxp.com/